

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination MATSUI ET AL.	
			Examiner Shean C. Wu	Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,348,043	03-2008	Fujita et al.	428/1.1
*	C	US-7,306,831	12-2007	Yamamoto, Hitoshi	428/1.1
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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